ORMETO 1449 (Modified)				ATTY. DOCKET NO. TH1407 (US) APPLICANT Y. Chen et al. FILING DATE November 22, 2000 ENTERDOCUMENTS APPLICATION NUMBER 09/718,690 GROUP ART UNIT 1764 Filing				`
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

^{1.} 2. The attached cited information should not be construed as an admission that any of the above items are prior art to the subject invention. This is not a representation that a search has been made.

FORM PTO-1449 (Modified)

JUN 1 7 2002

TTY. DOCKET NO. TH-1407

APPLICATION NUMBER 09/718,690

LIST OF INFORMATION PROVIDED

BY APPLICANT (Use several sheets if necessary) APPLICANT Ye-Mon Chen et al.

FILING DATE

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